## Notice of References Cited Application/Control No. 10/594,949 Examiner FARID KHAN Applicant(s)/Patent Under Reexamination SAKAMOTO ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
*	Α	US-2004/0002199	01-2004	Fukuyo et al.	438/460	
*	В	US-7,211,526	05-2007	Iri et al.	438/797	
	O	US-				
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	J	US-				
	K	US-				
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## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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